

Notice of References Cited	Application/Control No. 10/761,361	Applicant(s)/Patent Under Reexamination OGAWA ET AL.	
	Examiner TAN X. DINH	Art Unit 2627	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,434,091 B1	08-2002	Kuribayashi, Hiroki	369/275.4
*	B	US-2004/0095876 A1	05-2004	Abe, Shinya	369/275.4
*	C	US-7,184,391 B2	02-2007	Lee et al.	369/275.4
*	D	US-5,940,364 A	08-1999	Ogata et al.	369/275.4
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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